

Notice of References Cited	Application/Control No. 10/066,374	Applicant(s)/Patent Under Reexamination SUN ET AL.	
	Examiner Leda T. Pham	Art Unit 2834	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5,019,738	05-1991	Weilbach et al.	310/90.5
	C	US-6,340,854	01-2002	Jeong, Dae Hyun	310/90
	D	US-6,420,810	07-2002	Jeong, Dae Hyun	310/90.5
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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